# 2SA1535, 2SA1535A

## Silicon PNP epitaxial planar type

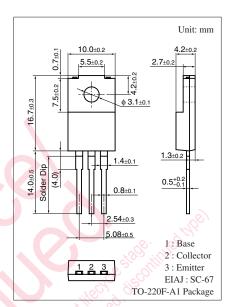
For low-frequency driver and high power amplification Complementary to 2SC3944, 2SC3944A

#### Features

- $\bullet$  Excellent collector current  $I_C$  characteristics of forward current transfer ratio  $h_{FE}$
- High transition frequency f<sub>T</sub>
- A complementary pair with 2SC3944 and 2SC3944A, is optimum for the driver-stage of a 60 W to 100 W output amplifier

### ■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit	
Collector-base voltage	2SA1535	$V_{CBO}$	-150	V
(Emitter open)	2SA1535A		-180	
Collector-emitter voltage	2SA1535	V <sub>CEO</sub>	-150	V
(Base open)	2SA1535A		-180	
Emitter-base voltage (Coll	V <sub>EBO</sub>	-5	V	
Collector current	$I_{C}$	-1	A	
Peak collector current	$I_{CP}$	-1.5	A	
Collector power dissipation	$T_C = 25^{\circ}C$	P <sub>C</sub>	15	W
			2	
Junction temperature		T <sub>j</sub>	150	°C
Storage temperature		T <sub>stg</sub>	-55 to +150	°C)



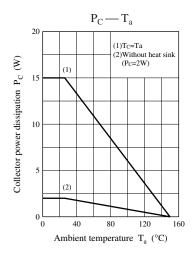
### ■ Electrical Characteristics $T_a = 25$ °C $\pm 3$ °C

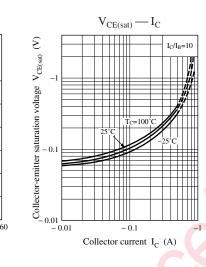
Parameter		Symbol	Conditions	Min	Тур	Max	Unit
Collector-emitter voltage	2SA1535	V <sub>CEO</sub>	$I_{\rm C} = -100 \; \mu A, \; I_{\rm B} = 0$	-150			V
(Base open)	2SA1535A	- MC	$I_{\rm C} = -100 \mu\text{A},  I_{\rm B} = 0$	-180			
Emitter-base voltage (Collector open)		V <sub>EBO</sub>	$I_E = -10  \mu A,  I_C = 0$	-5			V
Collector-base cutoff current (Emitter open)	2SA1535	$I_{CBO}$	$V_{CB} = -150 \text{ V}, I_E = 0$			-10	μА
Forward current transfer rat	io	h <sub>FE1</sub> *	$V_{CE} = -10 \text{ V}, I_{C} = -150 \text{ mA}$	65	160	330	_
		h <sub>FE2</sub>	$V_{CE} = -5 \text{ V}, I_{C} = -500 \text{ mA}$	50	100		
Collector-emitter saturation voltage		V <sub>CE(sat)</sub>	$I_C = -500 \text{ mA}, I_B = -50 \text{ mA}$		- 0.5	-2.0	V
Base-emitter saturation voltage		V <sub>BE(sat)</sub>	$I_C = -500 \text{ mA}, I_B = -50 \text{ mA}$		-1.0	-2.0	V
Transition frequency		$f_T$	$V_{CE} = -10 \text{ V}, I_{C} = -50 \text{ mA}, f = 10 \text{ MHz}$ 200		200		MHz
Collector output capacitance		C <sub>ob</sub>	$V_{CB} = -10 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		30	50	pF
(Common base, input open circuited)							

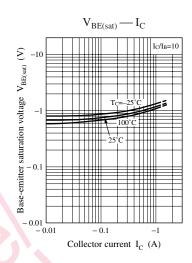
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

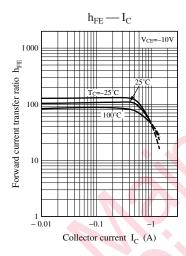
#### 2. \*: Rank classification

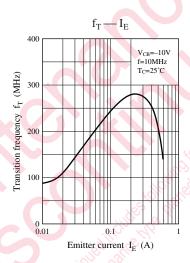
Rank	Р	Q	R	S
h <sub>FE1</sub>	65 to 110	90 to 155	130 to 220	185 to 330

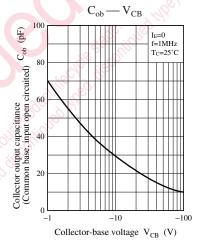


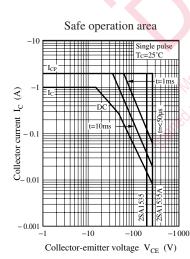












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